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UNIVERSITY OF THE WITWATERSRAND



A Burn-in Apparatus for the ATLAS Hadronic Tile- Calorimeter Phase-II Upgrade Transformer- Coupled Buck-Converters



National
Research
Foundation

Technology and Instrumentation in Particle Physics (TIPP2023)

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ATLAS Hadronic Tile-Calorimeter

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The ATLAS hadronic Tile-Calorimeter

TileCal Phase-II Upgrade Overview

finger Low-Voltage Power Supply

fLVPS Brick

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Talk Outline

The ATLAS Hadronic Tile-Calorimeter

- The Hadronic Tile-Calorimeter (TileCal) is a sampling calorimeter which forms the central region of the Hadronic calorimeter of the ATLAS experiment.
- It performs several critical functions within ATLAS such as the measurement and reconstruction of hadrons, jets, hadronic decays of τ -leptons, and missing transverse energy. It also participates in muon identification and provides inputs to the Level-1 calorimeter trigger system.
- TileCal is composed of 256 wedge-shaped modules which are arranged azimuthally around the beam axis. A module consists of alternating steel (absorber) tiles and plastic scintillating tiles (active medium) with a Super Drawer (SD) housing the Front-End (FE) electronics and the Photomultiplier tubes located on its outer radius.

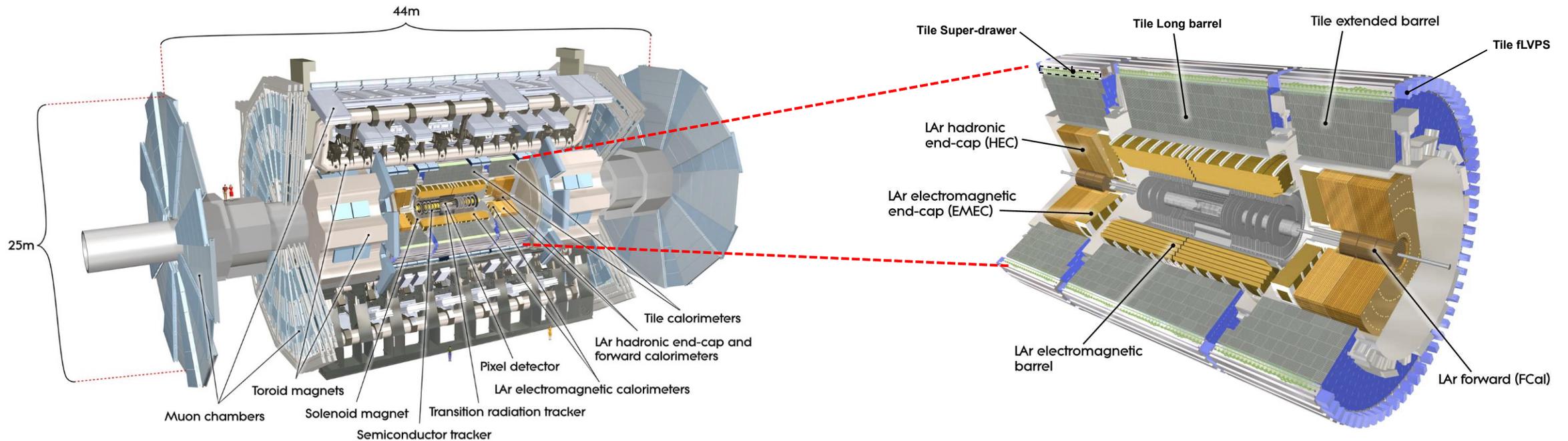
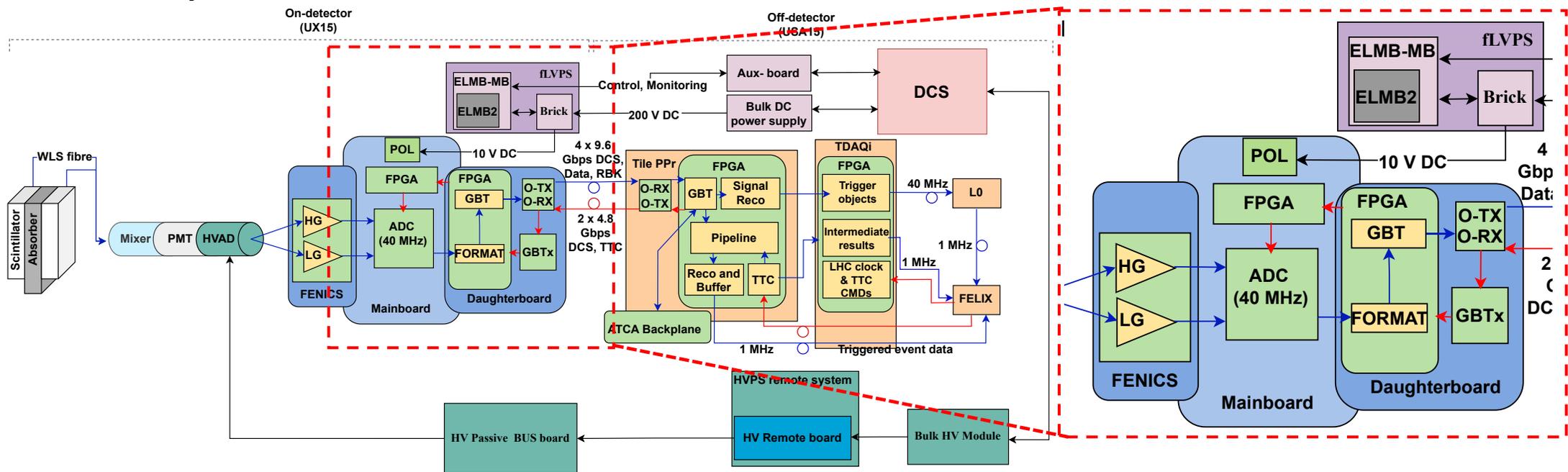


Fig.1 The ATLAS detector (Left). The ATLAS inner Barrel (Right) -J. Pequeno, Computer Generated image of the ATLAS calorimeter,(2008), <https://cds.cern.ch/record/1095927>

TileCal Phase-II Upgrade Overview

- In the year 2029 the start of the operation of the **High-luminosity Large Hadron Collider (HL-LHC)** is planned .
- **TileCal will be upgraded** to ensure peak performance within the HL-LHC environment.
- **New Front-end and Back-end electronics** - to stream data to trigger processor at 40 MHz crossing rate providing fully digital data to the trigger processors.
- **Replacement of 10% of PMTs** associated with the most exposed cells.
- **New mechanical frames** to house the front-end electronics.
- **HV(PMT)** will be controlled remotely.
- **LV: Unified Input to FE electronics power to 10V, individual Brick On/Off control.** See ref slide pg
- **Upgraded calibration systems** (Cesium and Laser).
- **Redundancy introduced in data links;**



Finger Low-Voltage Power Supply (2nd stage)

FE = Front-End
 ELMB = Embedded Local Monitoring Board
 ELMB-MB = ELMB Mother-Board

- 256 fLVPS within the TileCal (1 per module).
- Provides LV power to the FE electronics.
- Allows for power cycling of FE electronics.

Composed of:

- 8 Transformer-coupled buck converters (Bricks).
- ELMB2 mounted on ELMB-MB.
- Fuse board
- Cooling plate.
- Chassis

Component	Function
Power distribution	
Bulk 200 VDC	Input power
10 V Bricks	Convert 200VDC to 10VDC for FE electronics
Internal LV cable	Distribute the 10V DC to FE electronics
Brick control	
Auxiliary board cable	Transmit brick on/off signals from USA15
ELMB Motherboard	On/off control of bricks
Monitoring	
CanBus	Remote communication with ELMB2
Auxiliary board cable	Power to ELMB2
ELMB2	Temperature, voltage, current monitoring

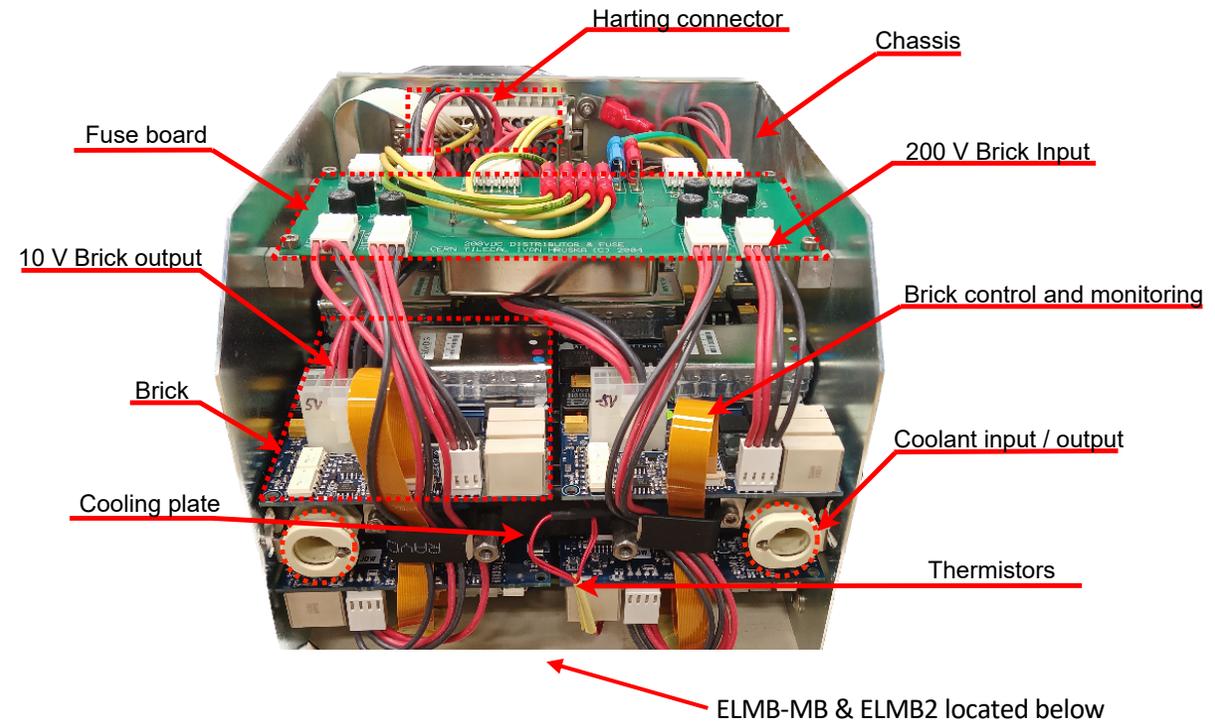


Fig. Fully populated legacy fLVPS without cover.

Embedded Local Monitoring Board (ELMB)
 Embedded Local Monitoring Board Mother-Board (ELMB-MB)

Phase-II Upgrade fLVPS Brick

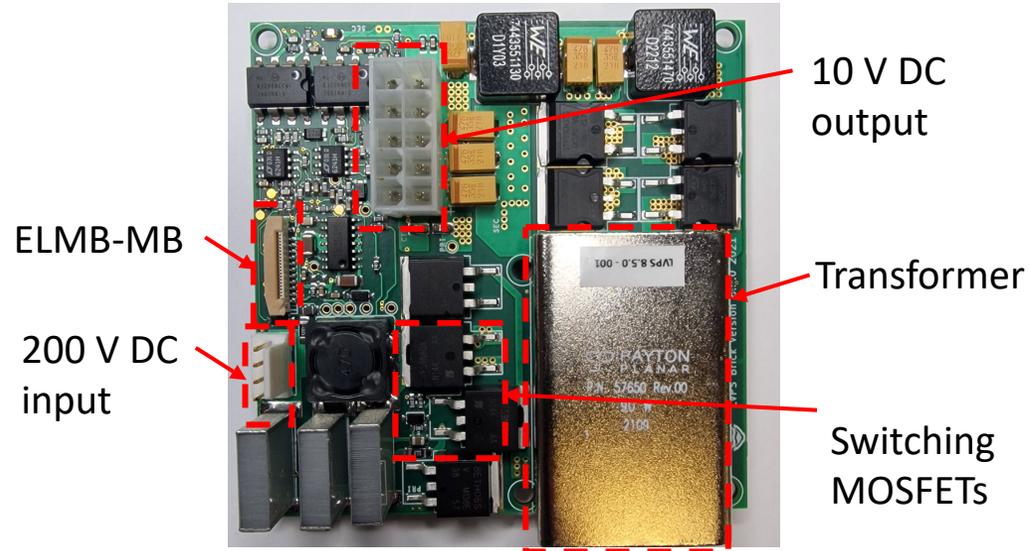


Fig. South African V8.5.0 LVPS Brick top view .

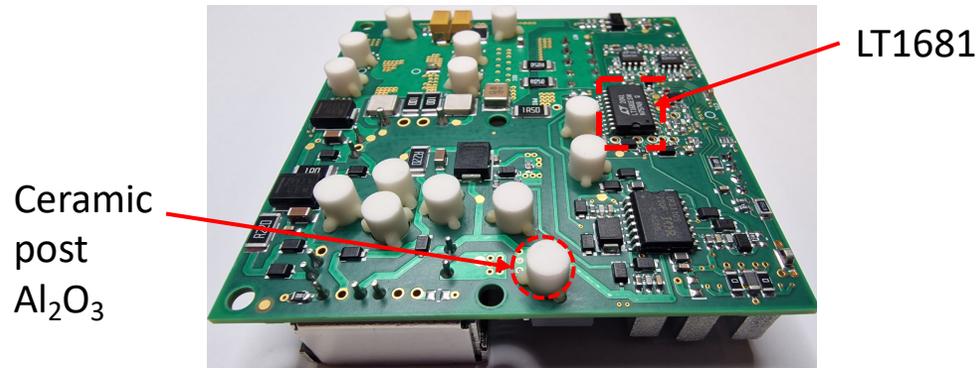


Fig. South African V8.5.0 LVPS Brick bottom view .

- A transformer-coupled buck converter.
- Converts bulk 200 V DC power to the 10 V DC which is then distributed to the Front-end electronics.
- Makes use of inbuilt protection circuitry – Over voltage protection, Over current protection and Over temperature protection.
- Production equally shared between USA (UTA) and SA (Wits).
- A total of 1128 LVPS Bricks to be locally produced in South Africa over the next two years (Pre- and Main-production).
- The required lifetime of a Brick within TileCal is ~ 20 years (End of Run-5).
- Current version V8.6.0

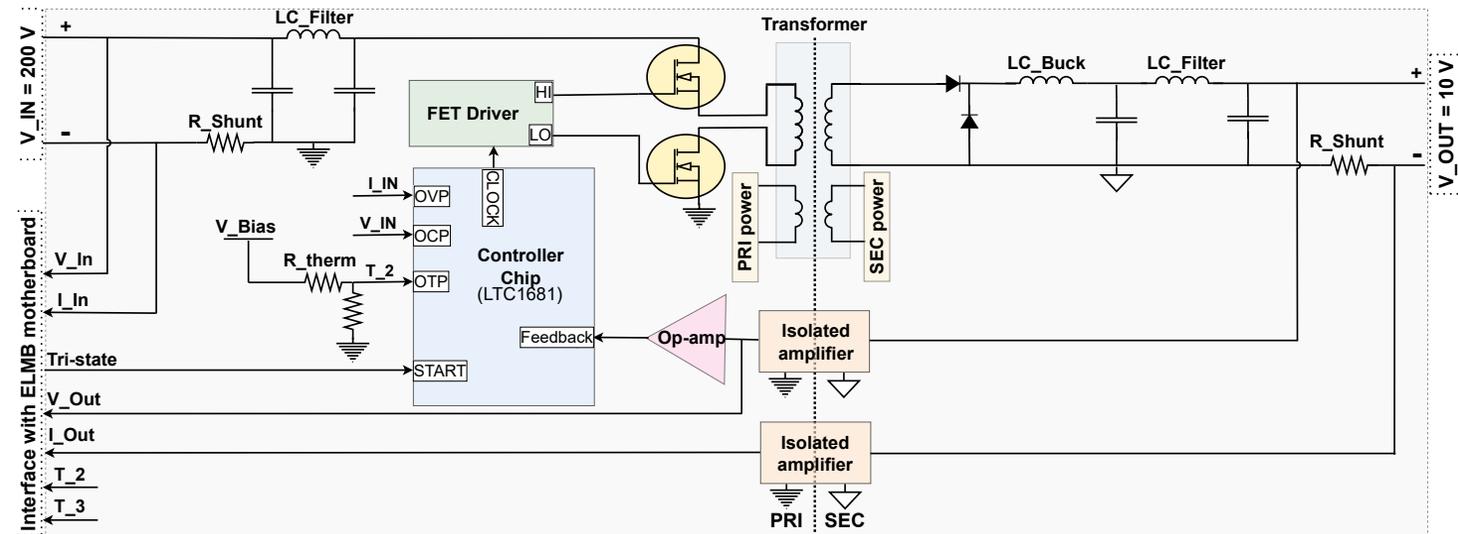
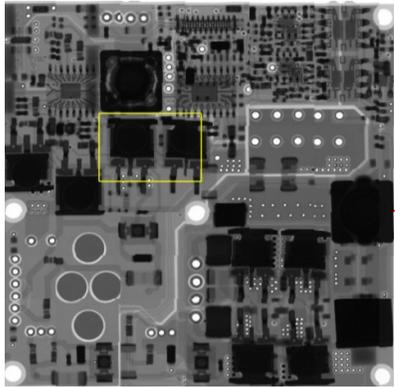


Fig. LVPS Brick functional block diagram.

fLVPS Brick Quality Assurance Testing



- Solder Voiding?

Performance metrics measured:

- Input/Output – Voltage/current
- Protection circuitry trip points (OVP, OCP)
- Tristate voltage level.

Identical to Initial Testing

- Identify performance “degradation” associated with burn-in.

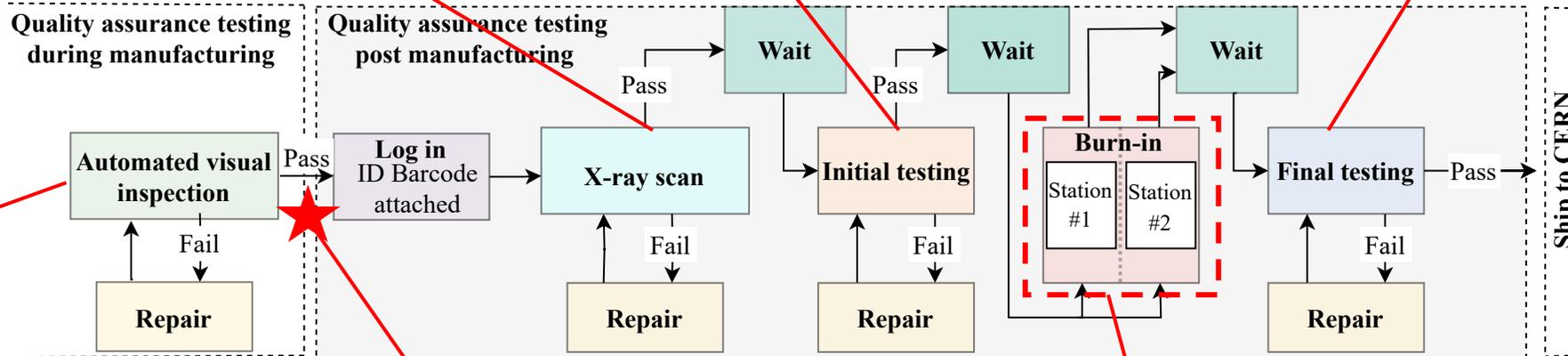


Fig.1 fLVPS Brick Quality assurance procedure.

Parallel operation due to “bottleneck”

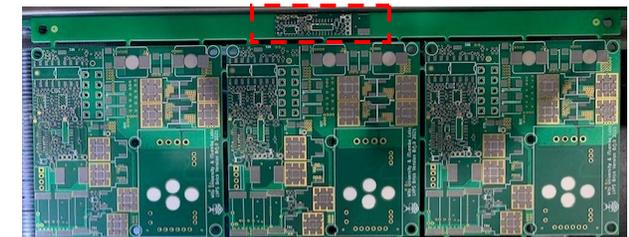
- Component placement?
- Reflow sliding?

Locally produced elements:

- ✓ Printed Circuit Boards
- ✓ Ceramic posts
- ✓ Production of final product



D-coupon testing has been newly introduced



Burn-in motivation

- Access to the Bricks is limited to approx. once per year.
=> Bricks and the FE electronics powered can be offline up to a year.
- Failure rate of electronics can be represented by a generalized "Bathtub" curve.
- Burn-in testing serves to address the infant mortality region by performing accelerated ageing of the Bricks.
- System level burn-in is to be undertaken
- Burn-in is primarily focused on detecting patent defects which appear during the early life of the Bricks.
- Latent defects, that usually appear during normal operation, can be converted into patent defects via external overstress.

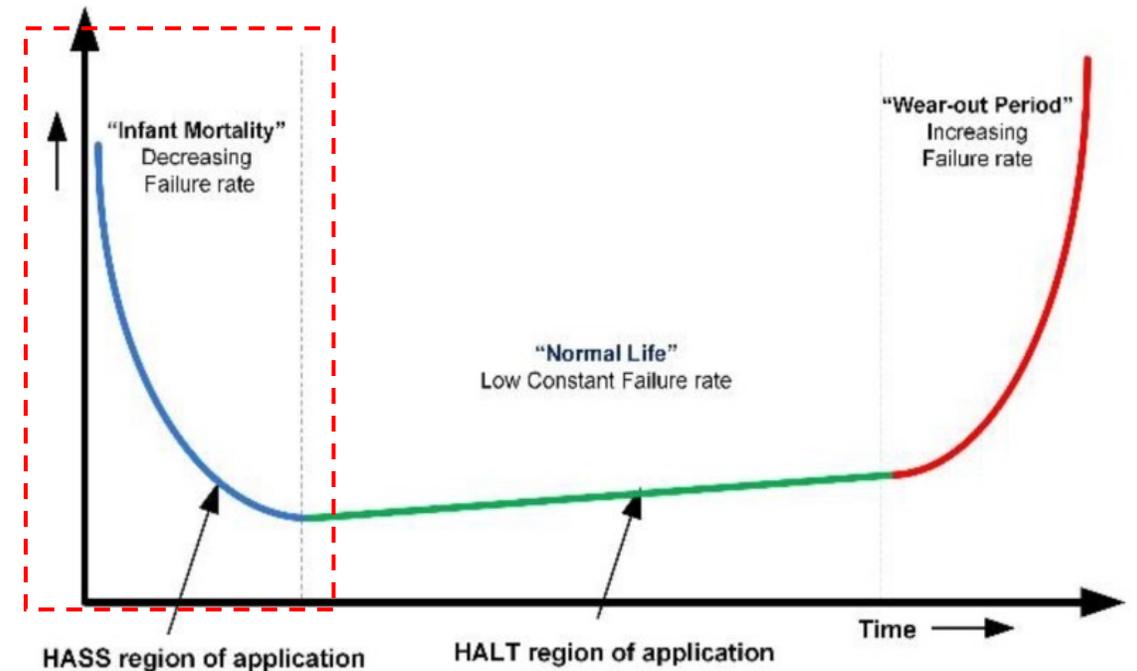


Fig. A Bathtub curve illustrating the failure rate as a function of time for electronic products. Muhammad.N et al. doi:10.3390/mi11030272.

Burn-in procedure

- The purpose of the Burn-in procedure is to accelerate aging of the Bricks.
- This is achieved by subjecting the Bricks to external overstress in the form of increased temperature and load.
- The Bricks operating temperature is increased by reducing the cooling capacity of the heatsinks (Cooling plates) to which they are attached.
- The Burn-in parameters are higher than nominal to ensure accelerated aging but have to remain below the limits imposed by the Bricks protection circuitry.

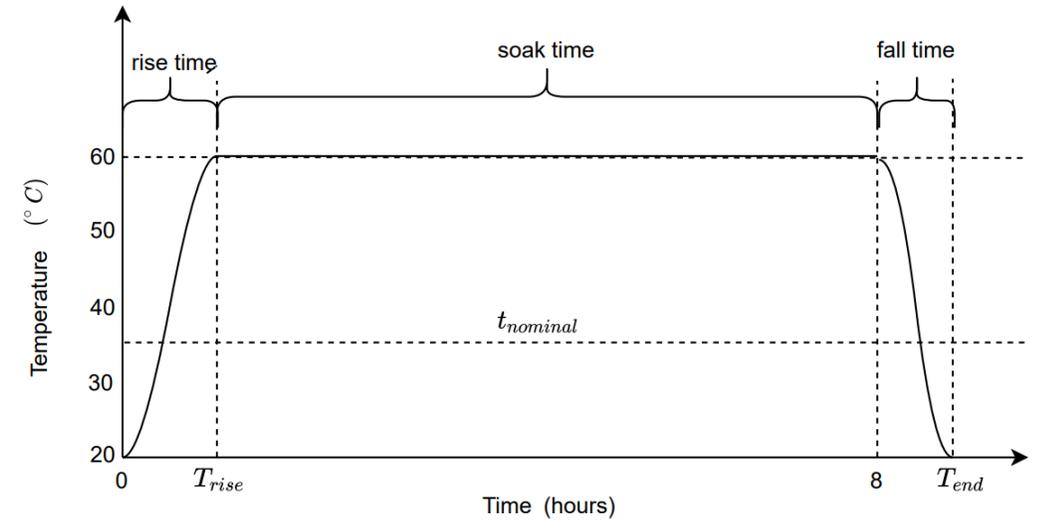


Fig. Generalized Phase-II upgrade Brick burn-in procedure thermal profile..

Parameter	Burn-in	Nominal	Protection circuitry trip points
Operating temperature	60° C	~ 35° C	70° C
Load	5 A	2.3 A	6.9 A
Run Time	8 hours**	-	-

Table : V8.6.0 Brick Burn-in parameters, nominal Brick operating parameters and protection circuitry trip points.

*The nominal operating temperature is heavily influenced by the primary side MOSFETS. ** The Burn-in run time is currently undergoing additional research. 8-hours is a legacy parameter.

Burn-in Test Station Overview

The Test station is composed of 4 elements which work together to facilitate the Burn-in of 8 Bricks per test cycle:

- **Test bed** – Required to contain the Burn-in station electronics, provide thermal and electrical insulation.
- **Cooling system** – Provides active cooling of the Bricks as well as the Dummy-Load boards. Allows for the control of the Bricks operating temperature.
- **Hardware**– Allow for control and monitoring of the Bricks and the applied load.
- **Software** – Allows for the control of the custom electronics, the HV power supply as well as the storage and real time viewing of data.

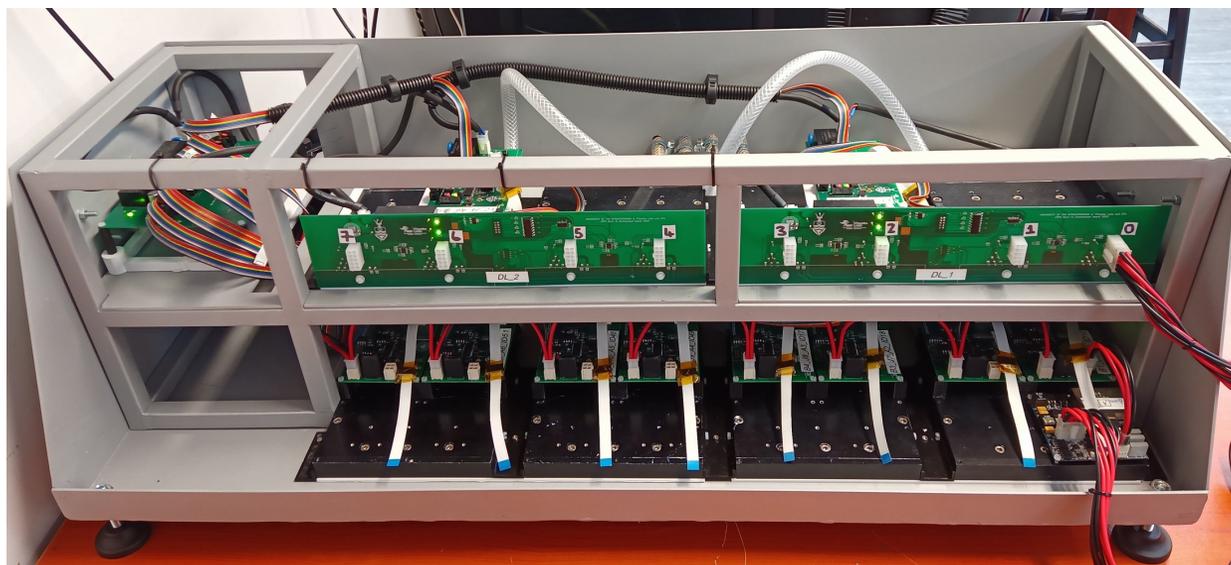


Fig.18 Burn-in station test-bed with top and front lids removed.

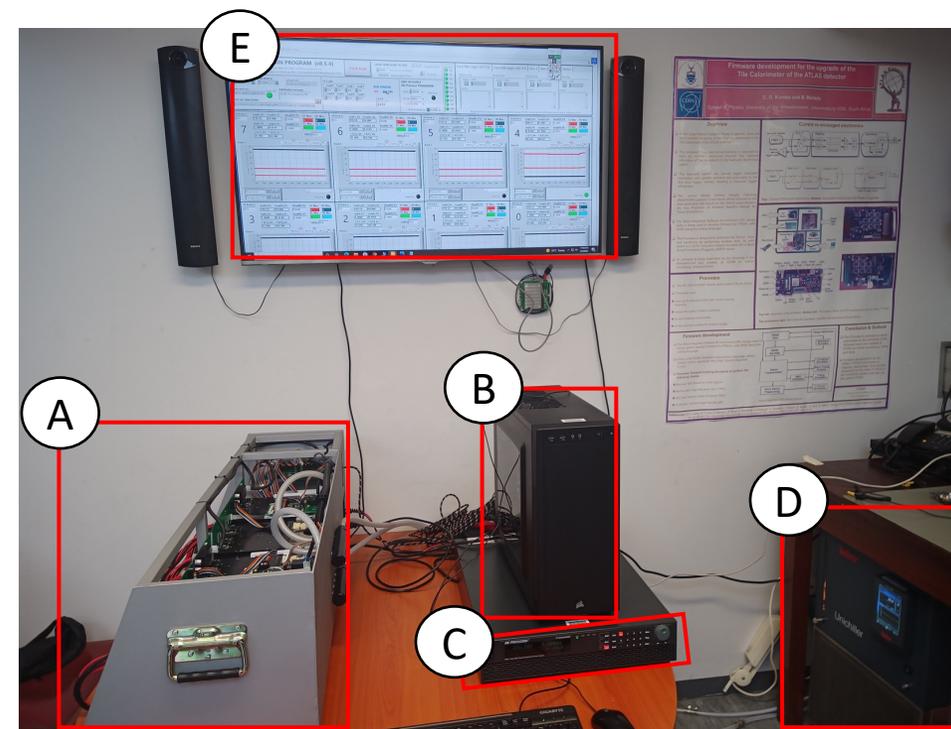


Fig. Burn-in test station.

- (A) Test-bed (B) PC (C) DC power supply (D) Water chiller (E) GUI

Burn-in Test Station Hardware

BIB = Burn-in Interface Board
 LIB = Load Interface Board
 MB = Main Board
 DLB = Dummy-Load Board
 HV = High Voltage
 PIC = Programmable Integrated Circuit
 BLA = Burn-in Labview Application
 CP = Cooling Plate
 VCCS = Voltage Controlled Current Sink

The hardware modules are categorized into 4 types:

- **Main Board (MB)** x1, responsible for communicating to the BIBs and LIBs through an application-specific control and monitoring program developed in LabVIEW.
- **Brick Interface Board (BIB)** x8, interface between the MB and the eight Bricks undergoing burn-in. They digitize performance metric analog signals (such as output voltage) received from the Bricks. The BIBs are also used to switch the Bricks on/off and act as a switch for the 200 V DC input to a Brick.
- **Load Interface Board (LIB)** x2, interface between the MB and DL boards. As with the BIBs they digitize performance measurements obtained from the DLs (voltage and current of the brick output measured at the DL). The LIBs also control the load current of a Brick via VCCS located on the DLs
- **Dummy Load Board (DLB)** x2, make use of 4 VCCS that use high precision op-amps and N-channel MOSFETs which are affixed to the CPs to dissipate the heat generated

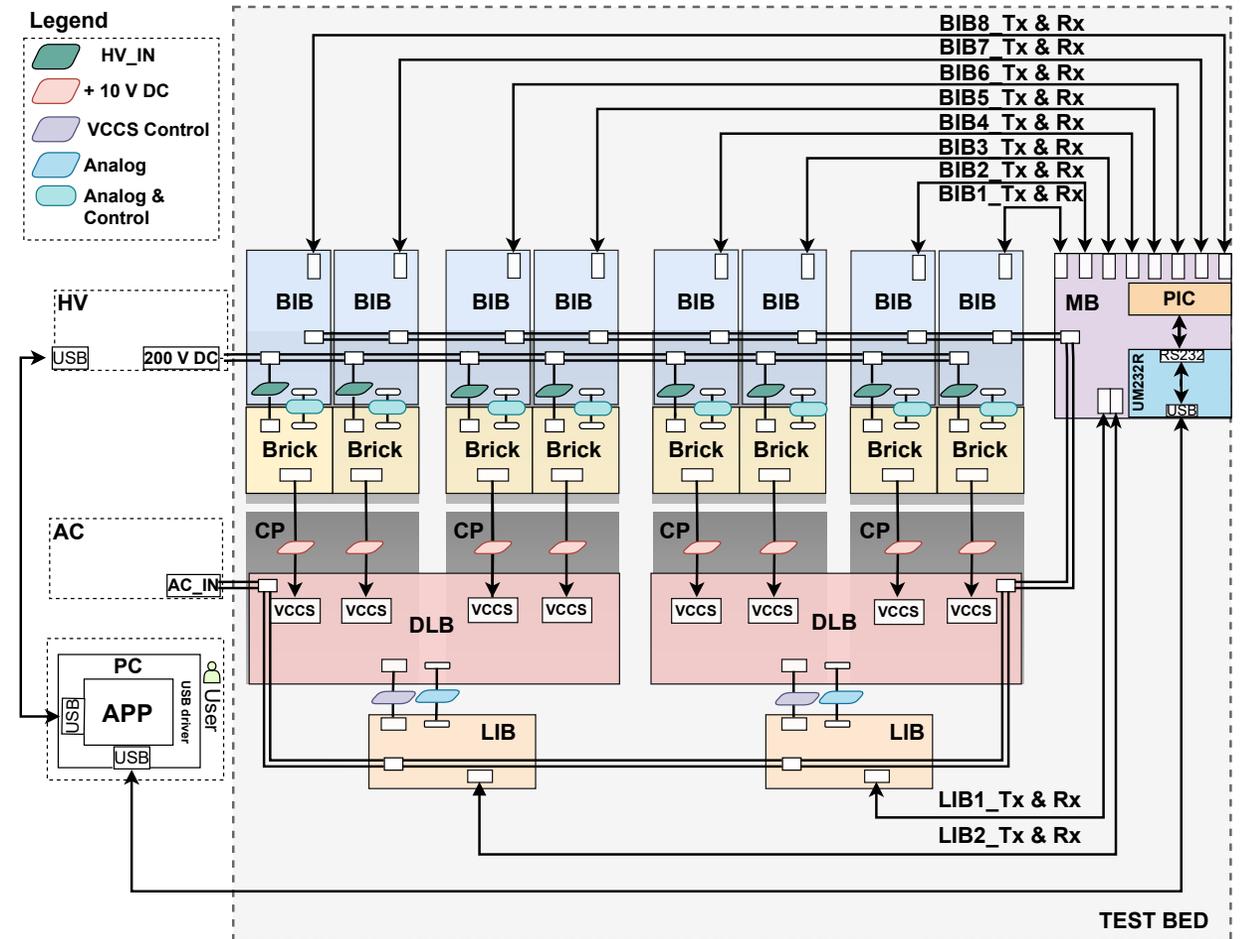


Fig. Block diagram illustrating the burn-in station hardware.

Burn-in Test Station Software

BIB = Burn-in Interface Board
 LIB = Load Interface Board
 MB = Main Board
 DL = Dummy-Load
 HV = High Voltage
 PIC = Programmable Integrated Circuit
 BLA = Burn-in Labview Application

- The Burn-in LabVIEW Application (BLA) and PIC firmware were originally developed by Argonne National Laboratory (ANL) in 2006 for the V6 Brick.

Software required for the operation of a Burn-in station can be divided into three categories:

- BLA** provides control and monitoring of the Burn-in station and communicates via a PC over USB to the MB and PVS60085MR HV power supply. A PC runs the BLA responsible for Brick identification, Brick selection, Brick control (starting, stopping and load current), Brick and load performance measurements, HV control and monitoring, Brick trip detection and automatic restart, Burn-in time management and data logging.
- PIC firmware** The MB embeds PIC firmware responsible for addressing and communicating from the BLA to the Interface boards of the Burn-in station.
- Power supply instrumentation driver** - software routines that control the programmable instrument.

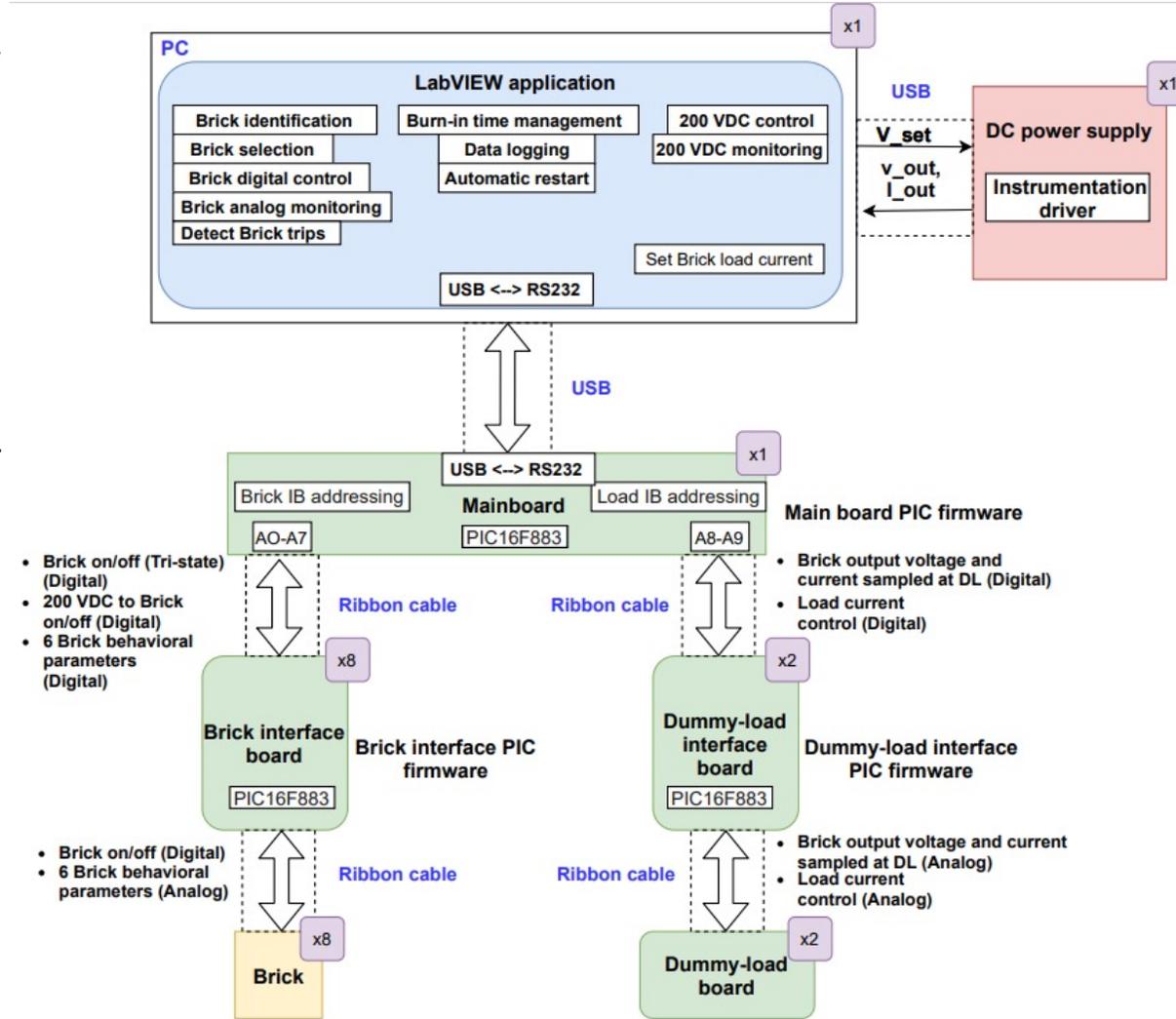


Fig. A simplified block diagram of the Burn-in station communication system..

Outlook – Towards Pre-production

Burn-in station design finalized

- Hardware and software are ready.

“Burning in” the Burn-in station.

- Commissioning of the first test station has been completed.
- Prolonged testing has highlighted that the VCCS MOSFETs were getting far too hot. Numerous protection Thermostat trips and shorted MOSFETs.
- A single cooling system for both the Bricks and Dummy-loads means that additional radiative cooling is the only option (Heatsink + Fan).

Replication

- The second Burn-in station is under construction. To be completed before main-production.

Pre-production

- Anticipated to commence in the coming months pending V8.6.0 approval
 - Mixed beam (CHARM) certification of active components.
- 104 units to be produced in SA. QA testing to take approx. 2 weeks.

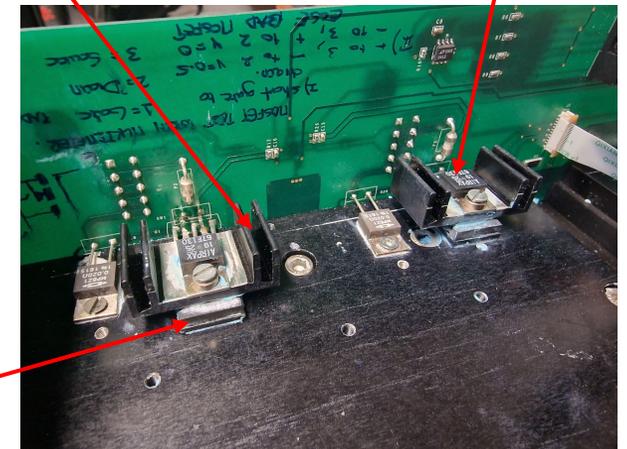
Main-production

- Anticipated to commence in early 2024.



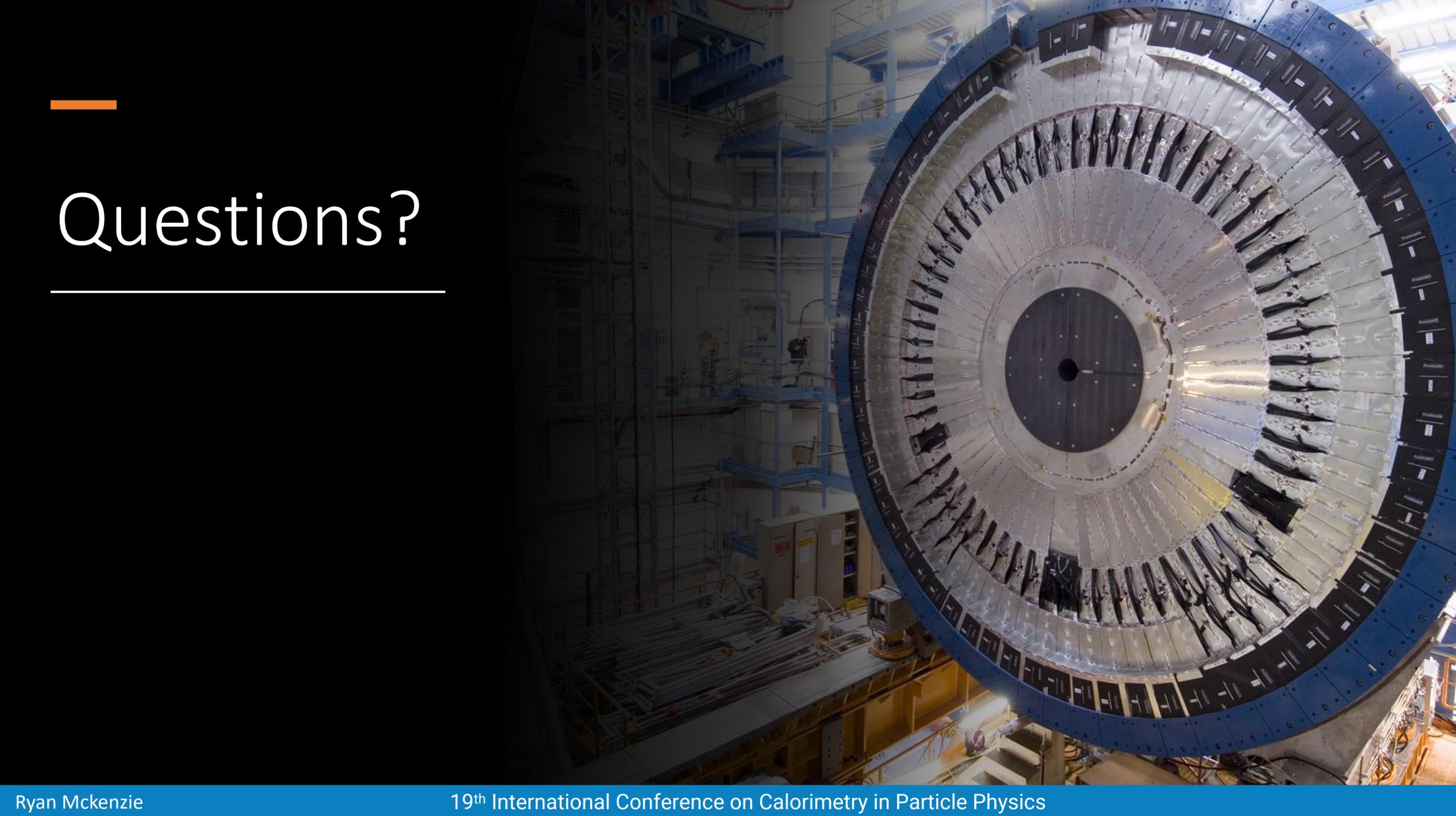
Fig. V8.4.2 Brick undergoing burn-in.

Heat sink Thermostat



VCCS MOSFET

Fig. Dummy-load VCCS connected to cooling plate.



Questions?

The HL-LHC Timeline



The ATLAS detector*

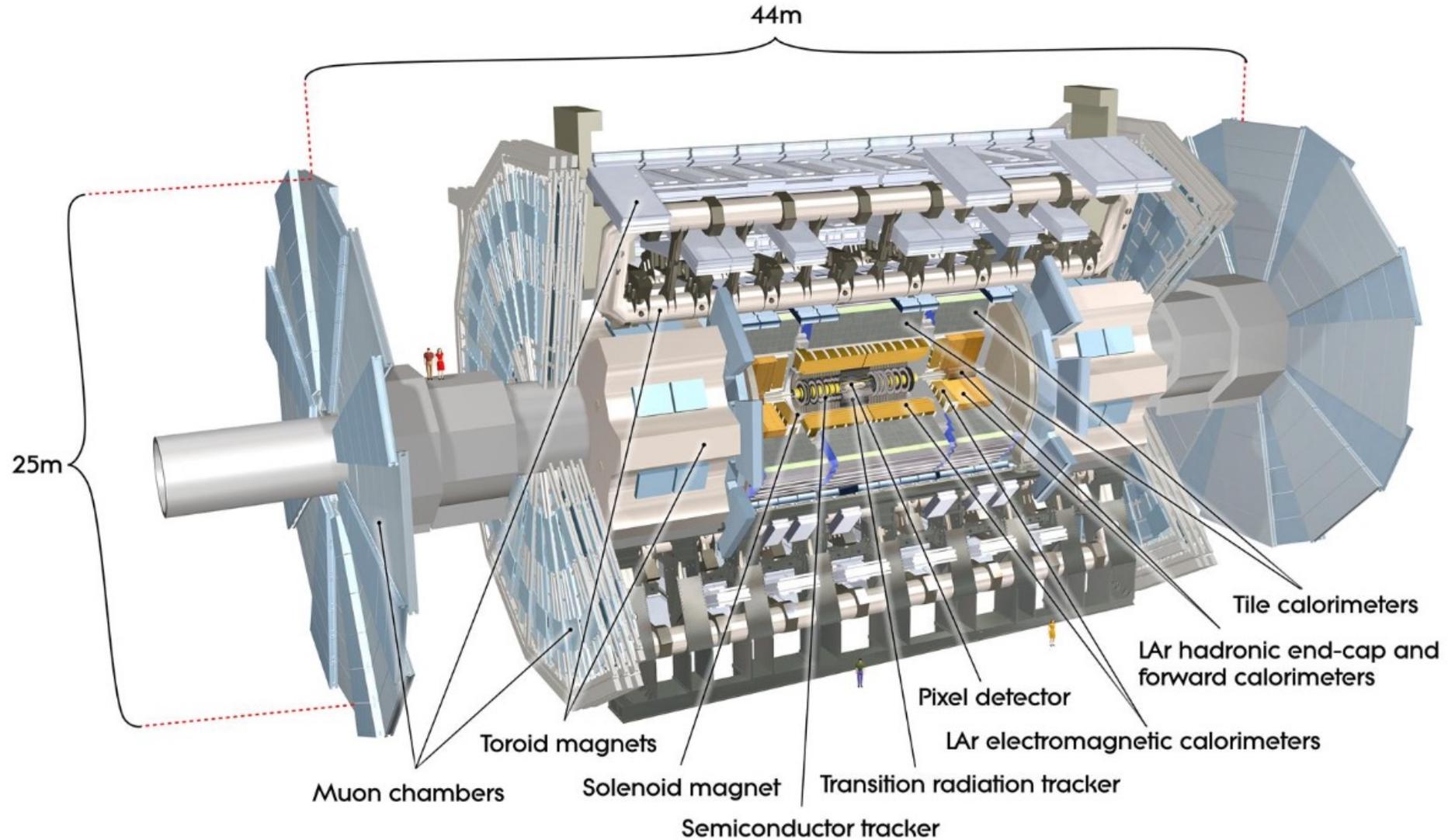


Fig.15 The ATLAS detector

* Pre-LS3

Legacy Low-Voltage System

- A **2-stage system** in which Bulk 200 VDC power is converted to the voltages required by the FE electronics by different types of Brick.
- **Provides ON/OFF control** (Via Aux-boards) of the bricks in two groups which start successively.

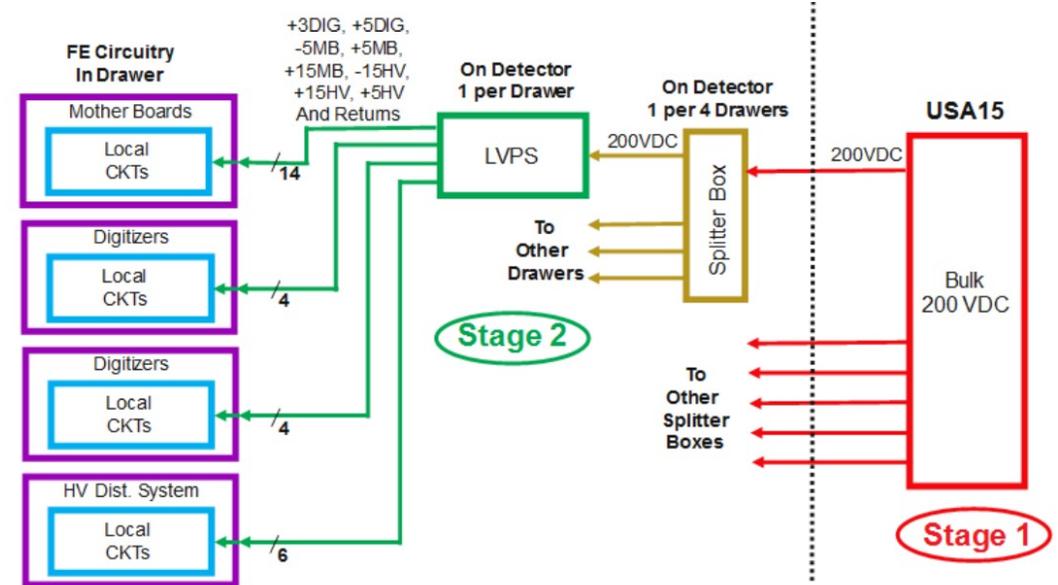


Fig. Block diagram of the legacy 2-stage low-voltage system.

Phase-II Upgrade

- **Conversion to a 3-stage system** which makes use of Point-of-load regulators (POLs). POLs function to step-down the 10 VDC received from an LVPS Brick to the voltage required by local circuits. This allows for the use of a single type of brick with a standardized 10V output;
- **Tri-state functionality** is being introduced which allows for individual Bricks startup/shutdown. This functionality is so named due to the Aux-boards ability to send 3 different state signals to an LVPS Brick;

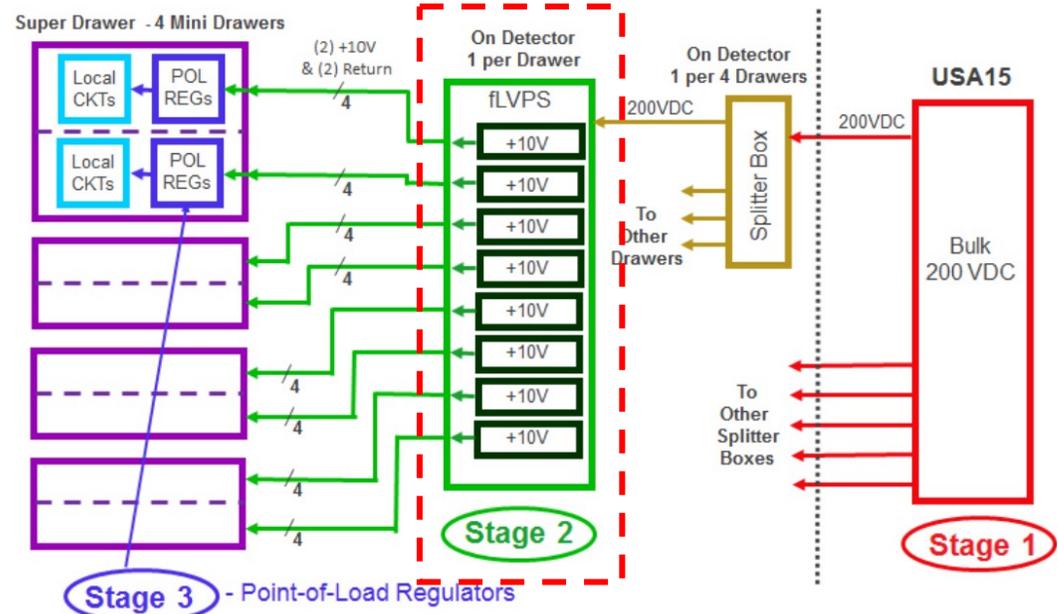
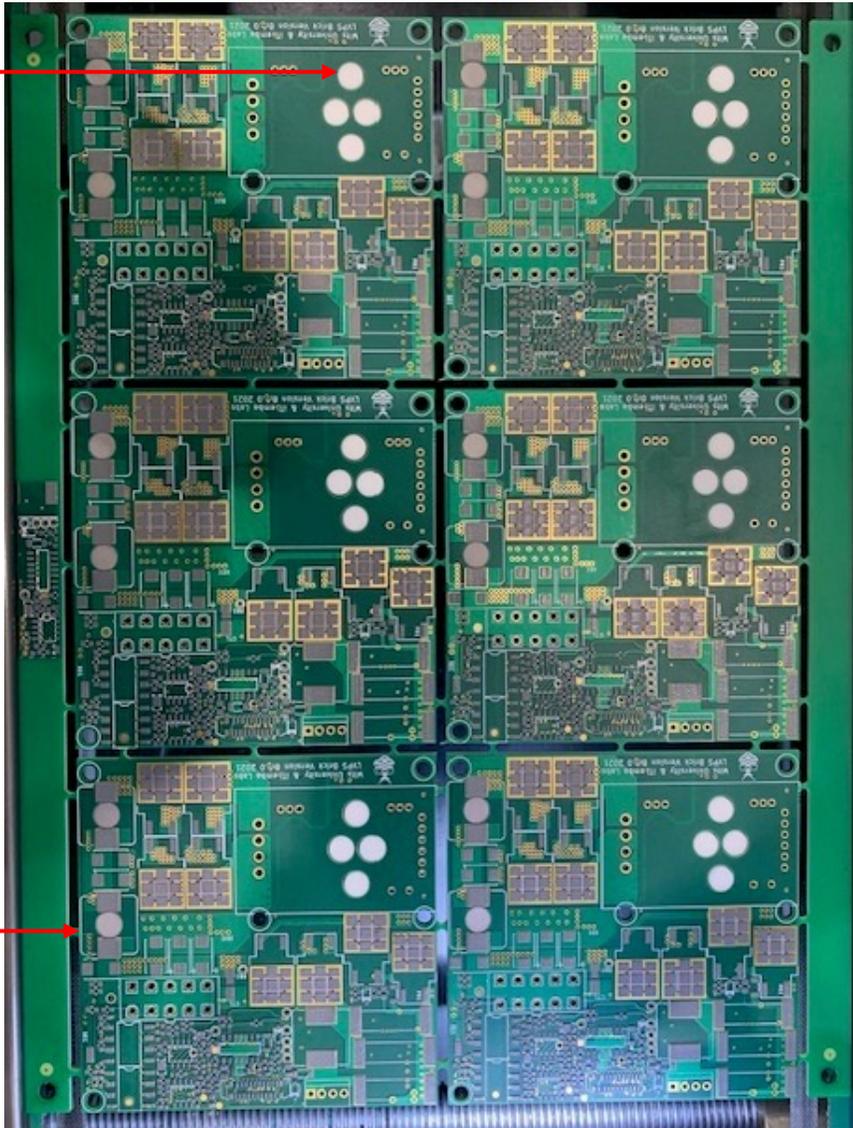


Fig. Block diagram of the Phase-II upgrade 3-stage low-voltage system.

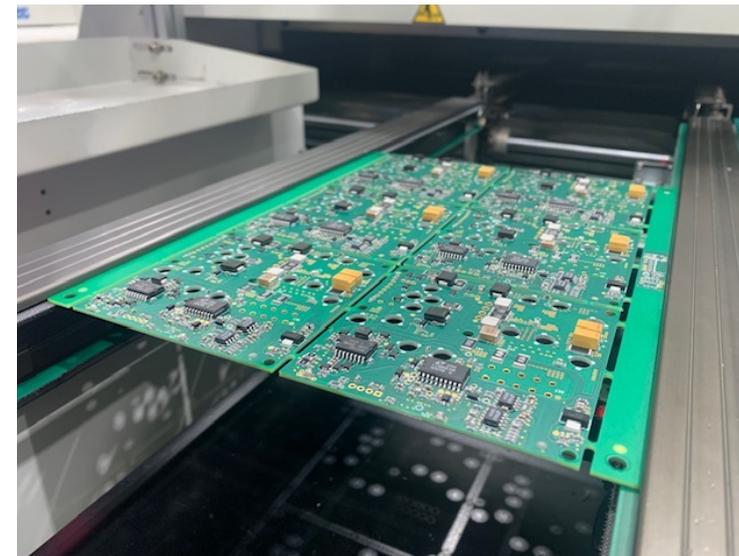
Brick Panel Population

Non-metalized



Metalized

Silver Palladium
Conductor



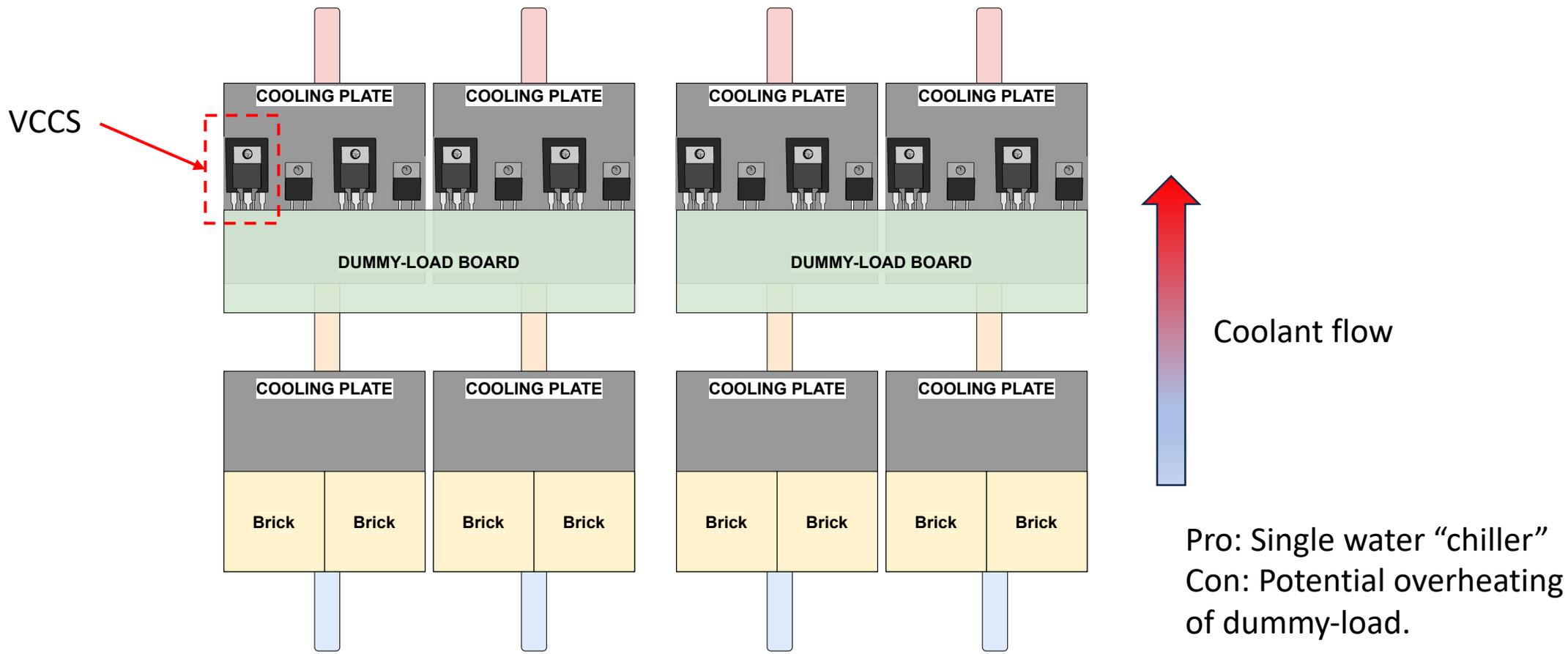
Brick Tri-state Signal

START = 15 or 17 V DC at the receiving end (brick), $I=150$ mA, duration 1 second. This signal initially powers the primary side of a brick. After starting, the brick primary side powers itself.

RUN = High impedance: only if the brick has already been started, the circuitry of the brick imposes a voltage of 6.0 ± 0.2 V on this Tri-State line, when it is in high impedance mode, which keeps the voltage regulator LM9074 enabled. However, if the brick is off, the high impedance state does not turn it on, as there is no voltage on the brick. So once a brick is turned off (for example due to a trip), only a START voltage can turn it back-on.

DISABLE < 2 V DC at the receiving end (brick), $I=0$ A. Line is simply shorted to ground on the AuxBoard. This signal state disables the LM9074 regulator on the brick, which will turn the brick off.

Burn-in station temperature control system



Pro: Single water "chiller"
Con: Potential overheating of dummy-load.

Burn-in station GUI

MAIN PROGRAM BURN-IN (WITS v8.5.4)

(c) Originally developed by B.Palan 03.02.2006, 29.3.2007 CERN for the ver.6 bricks
Revised/Modified/Tested by Roger van Rensburg, 2021, (c) University of the Witwatersrand (HTEL)

STOP RUN

LONG TERM BURN-IN TEST

00:00:00 Elapsed LT time
07:00 Time to run (HH:MM)
00:00:00 Remaining LT time
0 Ts [min]

RUN FOREVER

NO YES
Cycle#
0

200V HV SUPPLY (BK Precision PVS60085MR)

Vs[V] 200.00 V Updating_HV
Vin[V] 0.000 V
Iin[A] 0.0000 A
of Bricks Active 0 0.0000 A

Revisions Revisions (cont.) Notes Error Messages (B0-3) Messages (B0-7)

B4 Error Out		B5 Error Out		B6 Error Out		B7 Error Out	
status	code	status	code	status	code	status	code
✓	0	✓	0	✓	0	✓	0
source		source		source		source	
VISA Read in Brick_ReadValues_full.vi->brick_values.vi->Longterm_read.vi->WITS_MAIN_PR.vi		VISA Read in Brick_ReadValues_full.vi->brick_values.vi->Longterm_read.vi->WITS_MAIN_PR.vi		VISA Read in Brick_ReadValues_full.vi->brick_values.vi->Longterm_read.vi->WITS_MAIN_PR.vi		VISA Read in Brick_ReadValues_full.vi->brick_values.vi->Longterm_read.vi->WITS_MAIN_PR.vi	

USB PORT A: COM4
USB PORT B: COM3
OPERATOR: Roger van Rensburg

CARDS INPUT FILE: CARDS_BURNIN3.TXT
Cards OK? ●
Initialization message: BURN-IN Initialization OK

TEST FILE DIRECTORY:
C:\Users\Electronics LAB\Desktop\Wits Burnin Station 1\LabVIEW\Log

LT_Loads

Load 0	Load 1	Load 2	Load 3	Load 4	Load 5	Load 6	Load 7
0.0	0.0	3.0	3.0	0.0	0.0	0.0	0.0

ID Brick 7: NO

Vin[V]_B7	Vout[V]_B7	Vload[V]_B7	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B7	Iout[A]_B7	Iload[A]_B7	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B7	T3[°C]_B7	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 7

Time [min] Temp2 [oC] / Eff [%] Updating_B7

ID Brick 6: NO

Vin[V]_B6	Vout[V]_B6	Vload[V]_B6	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B6	Iout[A]_B6	Iload[A]_B6	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B6	T3[°C]_B6	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 6

Time [min] Temp2 [oC] / Eff [%] Updating_B6

ID Brick 5: NO

Vin[V]_B5	Vout[V]_B5	Vload[V]_B5	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B5	Iout[A]_B5	Iload[A]_B5	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B5	T3[°C]_B5	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 5

Time [min] Temp2 [oC] / Eff [%] Updating_B5

ID Brick 4: NO

Vin[V]_B4	Vout[V]_B4	Vload[V]_B4	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B4	Iout[A]_B4	Iload[A]_B4	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B4	T3[°C]_B4	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 4

Time [min] Temp2 [oC] / Eff [%] Updating_B4

ID Brick 3: NO

Vin[V]_B3	Vout[V]_B3	Vload[V]_B3	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B3	Iout[A]_B3	Iload[A]_B3	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B3	T3[°C]_B3	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 3

Time [min] Temp2 [oC] / Eff [%] Updating_B3

ID Brick 2: NO

Vin[V]_B2	Vout[V]_B2	Vload[V]_B2	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B2	Iout[A]_B2	Iload[A]_B2	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B2	T3[°C]_B2	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 2

Time [min] Temp2 [oC] / Eff [%] Updating_B2

ID Brick 1: NO

Vin[V]_B1	Vout[V]_B1	Vload[V]_B1	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B1	Iout[A]_B1	Iload[A]_B1	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B1	T3[°C]_B1	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 1

Time [min] Temp2 [oC] / Eff [%] Updating_B1

ID Brick 0: NO

Vin[V]_B0	Vout[V]_B0	Vload[V]_B0	T2_Max	Eff_Max
0.0000	0.0000	0.0000	0	0
Iin[A]_B0	Iout[A]_B0	Iload[A]_B0	T2_Min	Eff_Min
0.0000	0.0000	0.0000	0	0
T2[°C]_B0	T3[°C]_B0	Eff[%]	0.00	
0.0000	0.0000	0.0000		

Brick 0

Time [min] Temp2 [oC] / Eff [%] Updating_B0

TileCal Phase-II Upgrade Simplified Block Diagram

